


<b>Search Notes</b>  	<b>Application/Control No.</b>  10551564	<b>Applicant(s)/Patent Under Reexamination</b>  AVOLIO ET AL.
	<b>Examiner</b>  Loewe, Sun Jae Y	<b>Art Unit</b>  1626

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
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restriction requirement	12-10-2007	sl

INTERFERENCE SEARCH			
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